## Notice of References Cited Application/Control No. 10/695,461 Examiner Richard Pantoliano Jr Applicant(s)/Patent Under Reexamination KUNO ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0143819	10-2002	Han et al.	707/513
*	В	US-2003/0005412	01-2003	Eanes, James Thomas	717/120
*	C	US-2003/0115548	06-2003	Melgar, David O.	715/513
*	D	US-2004/0205101	10-2004	Radhakrishnan, Rakesh	709/200
*	Ε	US-2004/0162741	08-2004	Flaxer et al.	705/007
*	F	US-2004/0193635	09-2004	Hsu et al.	707/102
	G	US-			
	н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					<u> </u>

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	>	
	w	
	x	

<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.